

# Search Notes



Application/Control No.

10/567,680

Examiner

John Kreck

Applicant(s)/Patent under Reexamination

ONG, CHIN CHAI

Art Unit

3673

## SEARCHED

Class	Subclass	Date	Examiner
405	230		
	231		
	232		
	244		
	255	1/10/2007	JK
update		6/23/07	~

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
text		6/23/07	~

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST text attached	1/10/2007	JK